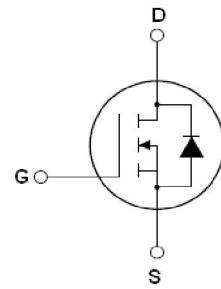


**SSF1006A**

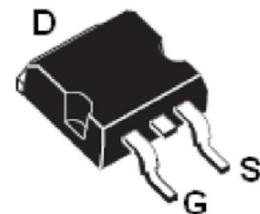
100V N-Channel MOSFET

**FEATURES**

- Advanced trench process technology
- avalanche energy, 100% test
- Fully characterized avalanche voltage and current
- Lead free product

**ID =200A****BV=100V****R<sub>DS(on)</sub>=4.7mΩ (Typ.)****DESCRIPTION**

The SSF1006A is a new generation of high voltage and low current N-Channel enhancement mode trench power MOSFET. This new technology increases the device reliability and electrical parameter repeatability. SSF1006A is assembled in high reliability and qualified assembly house.

**APPLICATIONS**

- Power switching application

**SSF1006A Top View (D2PAK)****Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @T <sub>c</sub> =25°C	Continuous drain current,VGS@10V	200	A
I <sub>D</sub> @T <sub>c</sub> =100°C	Continuous drain current,VGS@10V	130	
I <sub>DM</sub>	Pulsed drain current ①	800	
P <sub>D</sub> @T <sub>c</sub> =25°C	Power dissipation	272	W
	Linear derating factor	1.5	W/C
V <sub>GS</sub>	Gate-to-Source voltage	±20	V
E <sub>AS</sub>	Single pulse avalanche energy ②	960	mJ
E <sub>AR</sub>	Repetitive avalanche energy	TBD	mJ
dv/dt	Peak diode recovery voltage	31	v/ns
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to +150	°C

**Thermal Resistance**

	Parameter	Min.	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-case	—	0.46	—	C/W
R <sub>θJA</sub>	Junction-to-ambient	—	—	62	

**Electrical Characteristics @T<sub>J</sub>=25 °C (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source breakdown voltage	100	—	—	V	V <sub>GS</sub> =0V,I <sub>D</sub> =250μA
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	—	4.7	5.5	mΩ	V <sub>GS</sub> =10V,I <sub>D</sub> =30A
V <sub>GS(th)</sub>	Gate threshold voltage	2.0	—	4.0	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	2	μA	V <sub>DS</sub> =100V,V <sub>GS</sub> =0V



		—	—	10		V <sub>DS</sub> =100V, V <sub>GS</sub> =0V,T <sub>J</sub> =150°C
I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	nA	V <sub>GS</sub> =20V
	Gate-to-Source reverse leakage	—	—	-100		V <sub>GS</sub> =-20V
Q <sub>g</sub>	Total gate charge	—	108		nC	I <sub>D</sub> =30A,V <sub>GS</sub> =10V V <sub>DD</sub> =30V
Q <sub>gs</sub>	Gate-to-Source charge	—	24	—		
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	37	—		
t <sub>d(on)</sub>	Turn-on delay time	—	18.2		nS	V <sub>DD</sub> =30V I <sub>D</sub> =2A,R <sub>L</sub> =15Ω R <sub>G</sub> =2.5Ω V <sub>GS</sub> =10V
t <sub>r</sub>	Rise time	—	15.6			
t <sub>d(off)</sub>	Turn-Off delay time	—	70.5			
t <sub>f</sub>	Fall time	—	13.8			
C <sub>iss</sub>	Input capacitance	—	3150		pF	V <sub>GS</sub> =0V V <sub>DS</sub> =25V f=1.0MHZ
C <sub>oss</sub>	Output capacitance	—	350			
C <sub>rss</sub>	Reverse transfer capacitance	—	240			

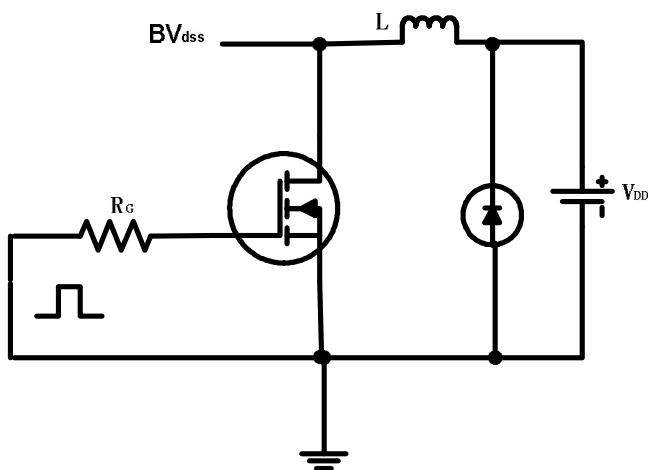
### Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	160	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	520		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.3	V	T <sub>J</sub> =25°C,I <sub>S</sub> =60A,V <sub>GS</sub> =0V ③
t <sub>rr</sub>	Reverse Recovery Time	—	57	—	nS	T <sub>J</sub> =25°C,I <sub>F</sub> =75A di/dt=100A/μs ③
Q <sub>rr</sub>	Reverse Recovery Charge	—	107	—	μC	
t <sub>on</sub>	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>s</sub> + LD)				

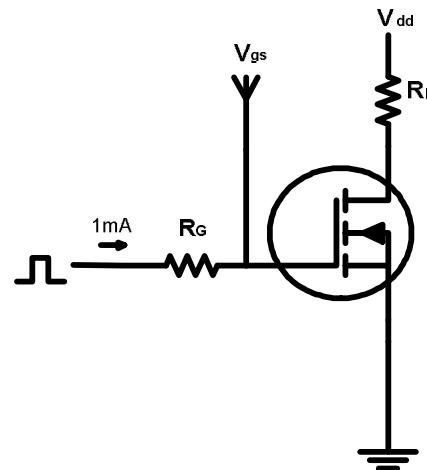
Notes:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Test condition: L = 0.3mH, V<sub>DD</sub> = 50V, I<sub>D</sub>=80A
- ③ Pulse width≤300μS, duty cycle≤1.5% ; R<sub>G</sub> = 25Ω Starting T<sub>J</sub> = 25°C

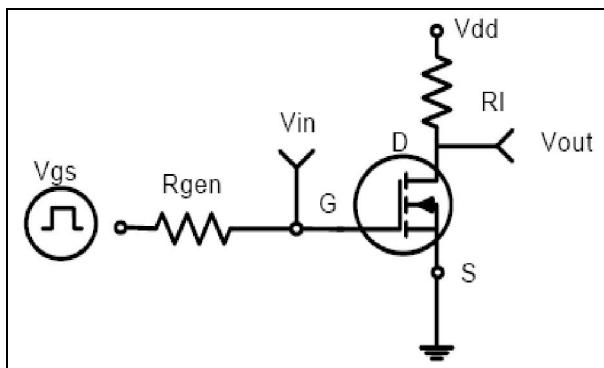
**EAS Test Circuit**



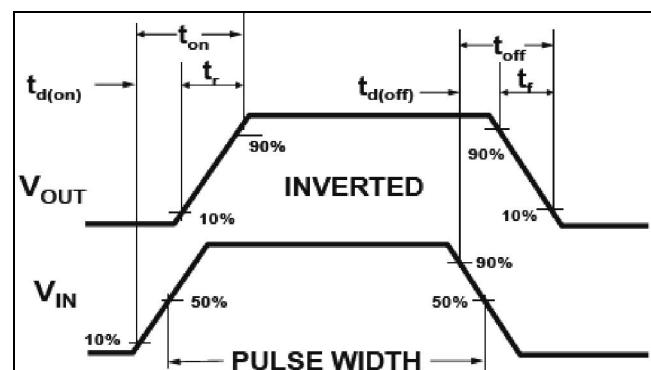
**Gate Charge Test Circuit**

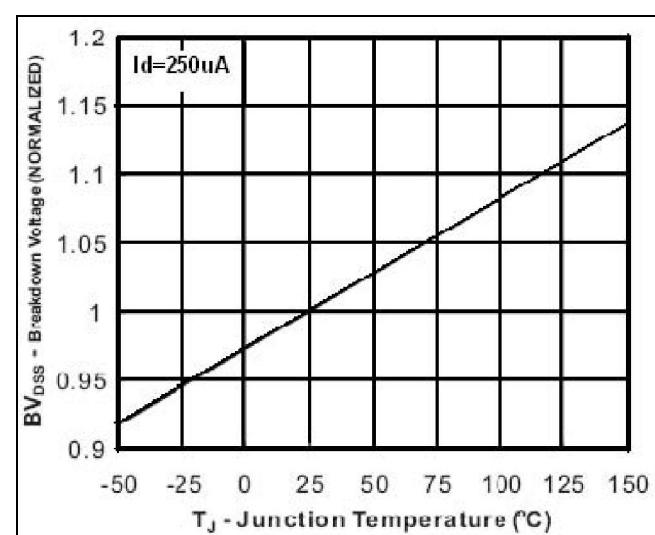
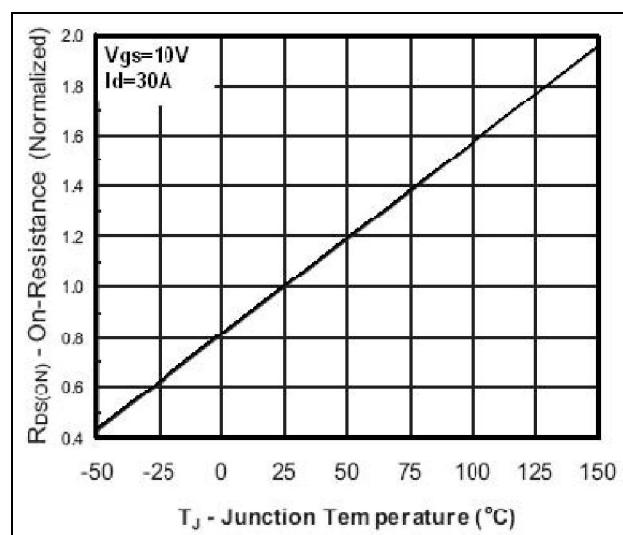
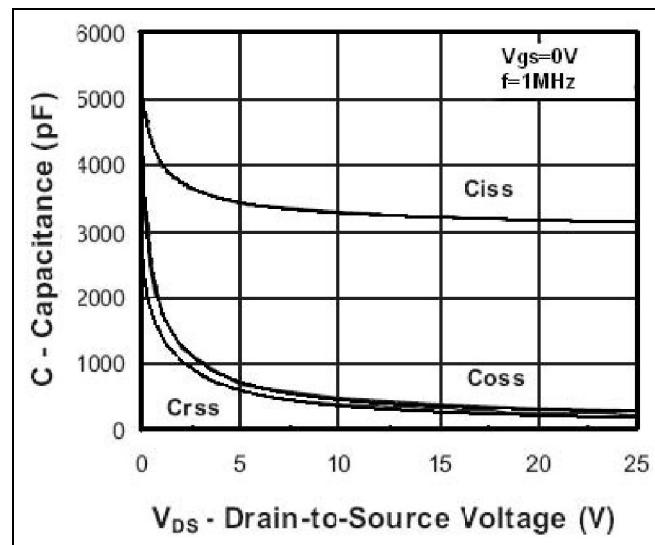
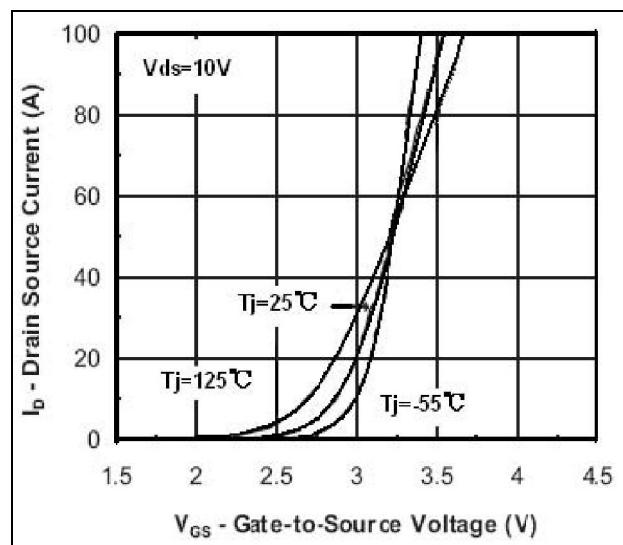


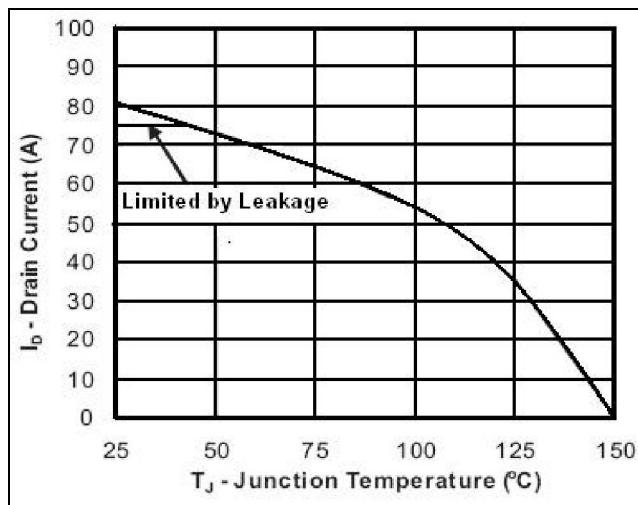
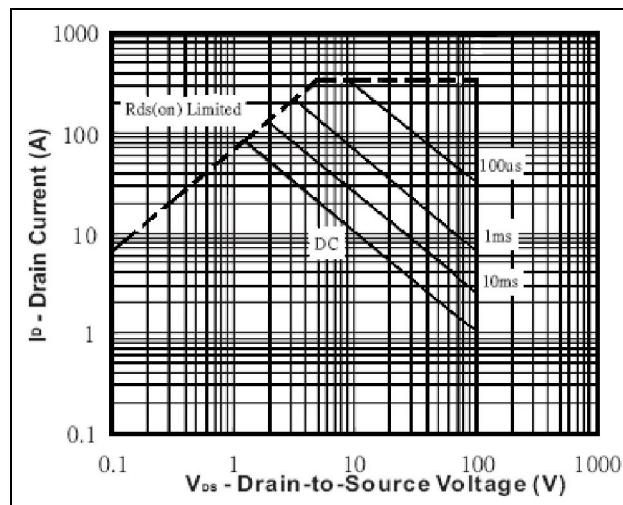
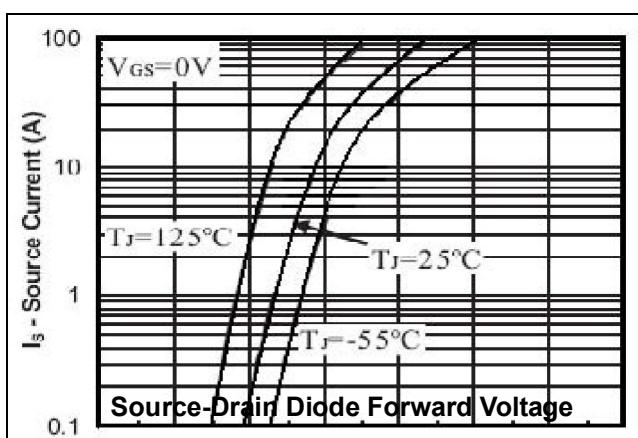
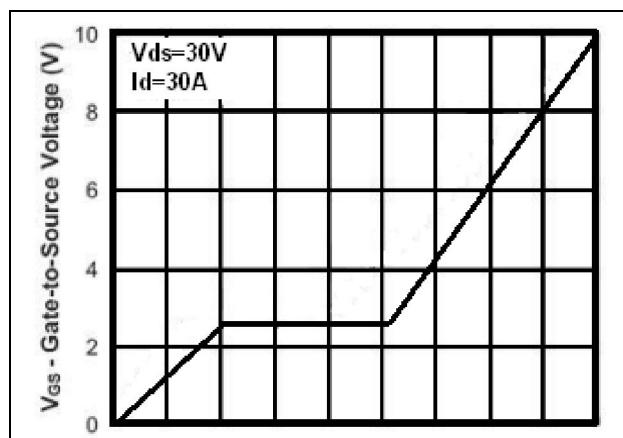
**Switch Time Test Circuit**



**Switch Waveform**

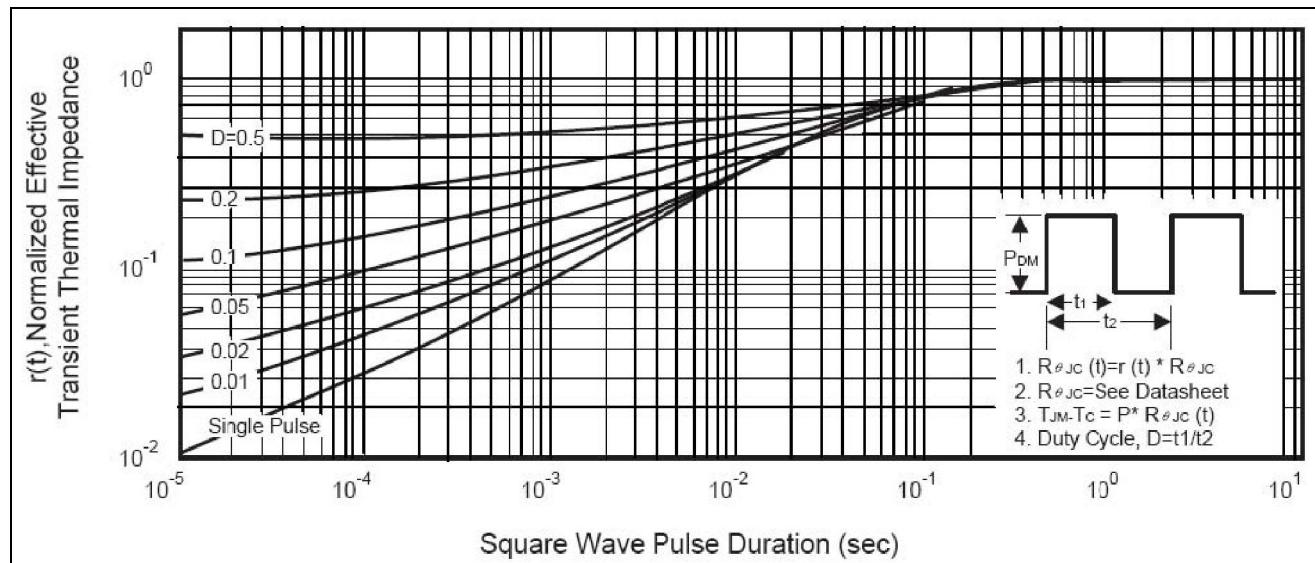






**Safe Operation Area**

**Max Drain Current vs. Junction**



**Transient Thermal Impedance Curve**

**D2PAK MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			

